Notice of References Cited Application/Control No. 10/812,174 Examiner Richard L. Leung Applicant(s)/Patent Under Reexamination ACHARYA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,904,046	05-1999	Kawano, Shin	62/6
	В	US-6,434,947 B2	08-2002	Zhu et al.	62/6
	С	US-			
	D	US-			
	Ε	US-		·	
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09296965 A	11-1997	Japan		F25B 09/00
	0					
	Р					
	Q					
	Ř					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.